

Application/Control No.	Applicant(s)/Patent under Reexamination
10/072,980	CHIU ET AL.
Examiner	Art Unit
Linda Krisciunas	3623

	SEAR	CHED	
Class	Subclass	Date	Examiner
705	7	3/20/2006	LMK
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East search (see attached)	3/20/2006	LMK	
Dialog search (see attached)	3/20/2006	LMK	
related cases	3/20/2006	LMK	